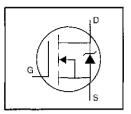
# International Rectifier

## IRLIZ24G

#### HEXFET® Power MOSFET

- Isolated Package
- High Voltage Isolation= 2.5KVRMS ®
- Sink to Lead Creepage Dist.= 4.8mm
- · Logic-Level Gate Drive
- Rps(on) Specified at Vgs=4V & 5V
- Fast Switching
- · Ease of Paralleling

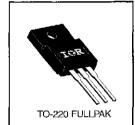


# $V_{DSS} = 60V$ $R_{DS(on)} = 0.10\Omega$ $I_D = 14A$

#### Description

Third Generation HEXFETs from International Rectifier provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220 Fullpak eliminates the need for additional insulating hardware in commercial-industrial applications. The moulding compound used provides a high isolation capability and a low thermal resistance between the tab and external heatsink. This isolation is equivalent to using a 100 micron mica barrier with standard TO-220 product. The Fullpak is mounted to a heatsink using a single clip or by a single screw fixing.



#### **Absolute Maximum Ratings**

***	Parameter	Max.	Units
I <sub>D</sub> @ T <sub>C</sub> = 25°C	Continuous Drain Current, Ves @ 5.0 V	14	
I <sub>D</sub> @ T <sub>C</sub> = 100°C	Continuous Drain Current, VGS @ 5.0 V	10	A
IDM	Pulsed Drain Current ①	56	
P <sub>D</sub> @ T <sub>C</sub> = 25°C_	Power Dissipation	37	W
	Linear Derating Factor	0.24	W/°C
V <sub>GS</sub>	Gate-to-Source Voltage	±10	ν
Eas	Single Pulse Avalanche Energy ②	100	mJ
dv/dt	Peak Diode Recovery dv/dt @	4.5	─ V/ns
Tj	Operating Junction and	-55 to +175	
T <sub>STG</sub>	Storage Temperature Range		_ °C
	Soldering Temperature, for 10 seconds	300 (1.6mm from case)	
	Mounting Torque, 6-32 or M3 screw	10 lbf•in (1.1 N•m)	:

#### Thermal Resistance

	Parameter	Min.	! Тур.	Max.	Units
Rauc	Junction-to-Case			4.1	- °C/W
Reja	Junction-to-Ambient		_	65	

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#### Electrical Characteristics @ T<sub>J</sub> = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Test Conditions
V <sub>(BR)DSS</sub>	. Drain-to-Source Breakdown Voltage	60	_	_	٧	V <sub>GS</sub> =0V, I <sub>D</sub> = 250μA
$\Delta V_{(BR)DSS}/\Delta T_{\rm J}$	Breakdown Voltage Temp. Coefficient		0.065	_	V/°C	Reference to 25°C, I <sub>D</sub> = 1mA
Ros(on)	Static Drain-to-Source On-Resistance	_		0.10	Ω	V <sub>GS</sub> =5.0V, I <sub>D</sub> =8.4A ④
	State Brain to Course On Tresistance		. —	0.14	3.2	. V <sub>GS</sub> =4.0V, I <sub>D</sub> =7.0A ⊕
V <sub>GS(th)</sub>	Gate Threshold Voltage	1.0	_	2.0	V	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> = 250μA
g <sub>fs</sub>	Forward Transconductance	7.3	i —		S	V <sub>DS</sub> =25V, I <sub>D</sub> =8.4A ④
· lpss	Drain-to-Source Leakage Current	_	_	25		V <sub>DS</sub> =60V, V <sub>GS</sub> =0V
IDSS	Dian-to-cource Leakage Current	-	_	250	μA	V <sub>DS</sub> =48V, V <sub>GS</sub> =0V, T <sub>J</sub> =150°C
I <sub>GSS</sub>	Gate-to-Source Forward Leakage	_	I -	100	пА	V <sub>GS</sub> =10V
IGSS	Gate-to-Source Reverse Leakage	_	_	-100	IIA	V <sub>GS</sub> =-10V
$Q_g$	Total Gate Charge	_	_	18		Ip=17A
Qgs	Gate-to-Source Charge	_		4.5	лC	V <sub>DS</sub> =48V
$Q_{gd}$	Gate-to-Drain ("Miller") Charge	-	_	12	]	V <sub>GS</sub> =5.0V See Fig. 6 and 13 @
<sup>†</sup> d(on)	Turn-On Delay Time	- Parker	11			V <sub>DD</sub> =30V
tr	Rise Time	_	110	_	ns	I <sub>D</sub> =17A
t <sub>d(off)</sub>	Turn-Off Delay Time		23		lia i	R <sub>G</sub> =9.0Ω
t <sub>f</sub>	Fall Time		41	_		R <sub>D</sub> =1.7Ω See Figure 10 ④
L <sub>D</sub>	Internal Drain Inductance	_	4.5		nHi i	Between lead, 6 mm (0.25in.)
Ls	Internal Source Inductance	_	7.5	_	IIH	from package and center of die contact
Ciss	Input Capacitance	_	870	_		V <sub>GS</sub> =0V
Cess	Output Capacitance		360	_	рF	V <sub>DS</sub> = 25V
C <sub>rss</sub>	Reverse Transfer Capacitance	_	53			f=1.0MHz See Figure 5
С	Drain to Sink Capacitance		12	_	pΕ	f=1.0MHz

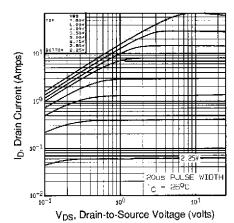
#### Source-Drain Ratings and Characteristics

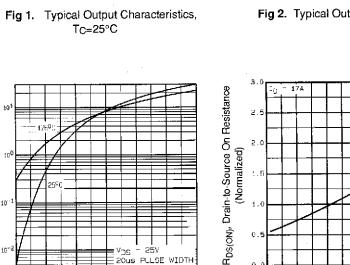
	Parameter	Min.	Тур.	Max.	Units	Test Conditions
ls	Continuous Source Current (Body Diode)	-	-	14		MOSFET symbol showing the
lsм .	Pulsed Source Current (Body Diode) ①	-	_	56	. A	integral reverse p-n junction diode.
Vsp	Diode Forward Voltage	_	_	1.5	V	TJ=25°C, Is=14A, VGS=0V @
ţrr	Reverse Recovery Time	_	130	260	ns	T <sub>J</sub> =25°C, I <sub>F</sub> =17A
Q <sub>rr</sub>	Reverse Recovery Charge	-	0.75	1.5	μC	di/dt=100A/μs ④
ton	Forward Turn-On Time	Intrinsio	Intrinsic turn-on time is neglegible (turn-on is dominated by Ls+Lp)			

#### Notes:

- Repetitive rating; pulse width limited by max, junction temperature (See Figure 11)
- ③ I<sub>SD</sub>≤17A, di/dt≤140A/μs, V<sub>DD</sub>≤V<sub>(BR)</sub>DSS, T<sub>J</sub>≤175°C
- ②  $V_{DD}$ =25V, starting  $T_J$ =25°C, L=595μH  $R_G$ =25Ω,  $I_As$ =14A (See Figure 12)
- ④ Pulse width < 300 µs; duty cycle ≤2%.</p>

(5) t=60s, f=60Hz





V<sub>GS</sub>, Gate-to-Source Voltage (volts)

Fig 3. Typical Transfer Characteristics

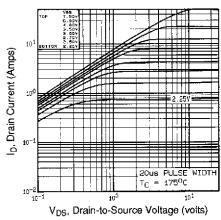


Fig 2. Typical Output Characteristics, Tc=175°C

Fig 4. Normalized On-Resistance Vs. Temperature

T<sub>J</sub>, Junction Temperature (°C)

40 60 80 100 :20 140 160 180

ID, Drain Current (Amps)

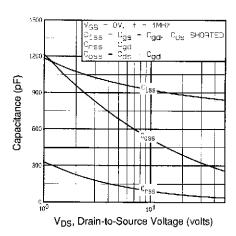


Fig 5. Typical Capacitance Vs. Drain-to-Source Voltage

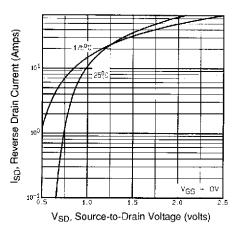


Fig 7. Typical Source-Drain Diode Forward Voltage

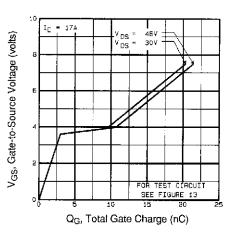


Fig 6. Typical Gate Charge Vs. Gate-to-Source Voltage

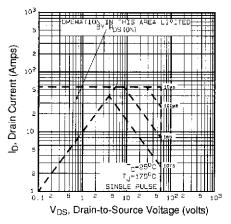


Fig 8. Maximum Safe Operating Area

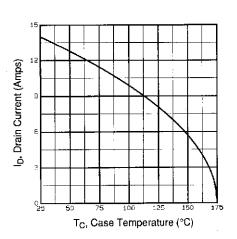


Fig 9. Maximum Drain Current Vs. Case Temperature

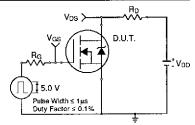


Fig 10a. Switching Time Test Circuit

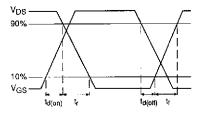


Fig 10b. Switching Time Waveforms

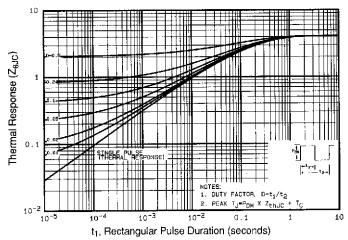


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

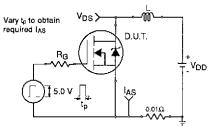


Fig 12a. Unclamped Inductive Test Circuit

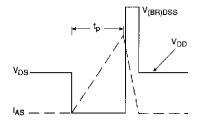


Fig 12b. Unclamped Inductive Waveforms

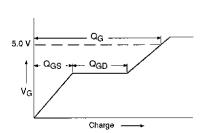


Fig 13a. Basic Gate Charge Waveform

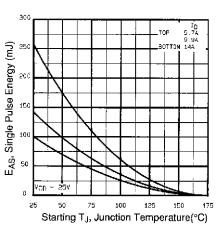


Fig 12c. Maximum Avalanche Energy Vs. Drain Current

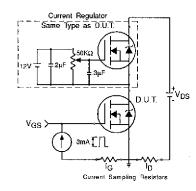


Fig 13b. Gate Charge Test Circuit

Appendix A: Figure 14, Peak Diode Recovery dv/dt Test Circuit -- See page 1505

Appendix B: Package Outline Mechanical Drawing - See page 1510

Appendix C: Part Marking Information - See page 1517





Vishay

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